

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 09/897,644 | Applicant(s)/Patent Under Reexamination PITTMAN ET AL. | |
| | Examiner Mark H Paschall | Art Unit 3742 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| | A | US-5,361,215 | 11-1994 | Tompkins et al. | 700/300 |
| | B | US-5,325,822 | 07-1994 | Fernandez, Guillermo N. | 392/491 |
| | C | US-5,968,393 | 10-1999 | Demaline, John Tracey | 219/492 |
| | D | US-6,212,894 | 04-2001 | Brown et al. | 62/180 |
| | E | US-3,791,863 | 02-1974 | Quirk, Virgil P. | 392/459 |
| | F | US-6,342,997 | 01-2002 | Khadkikar et al. | 361/103 |
| | G | US-5,872,890 | 02-1999 | LaCombe, Thomas David | 392/487 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.